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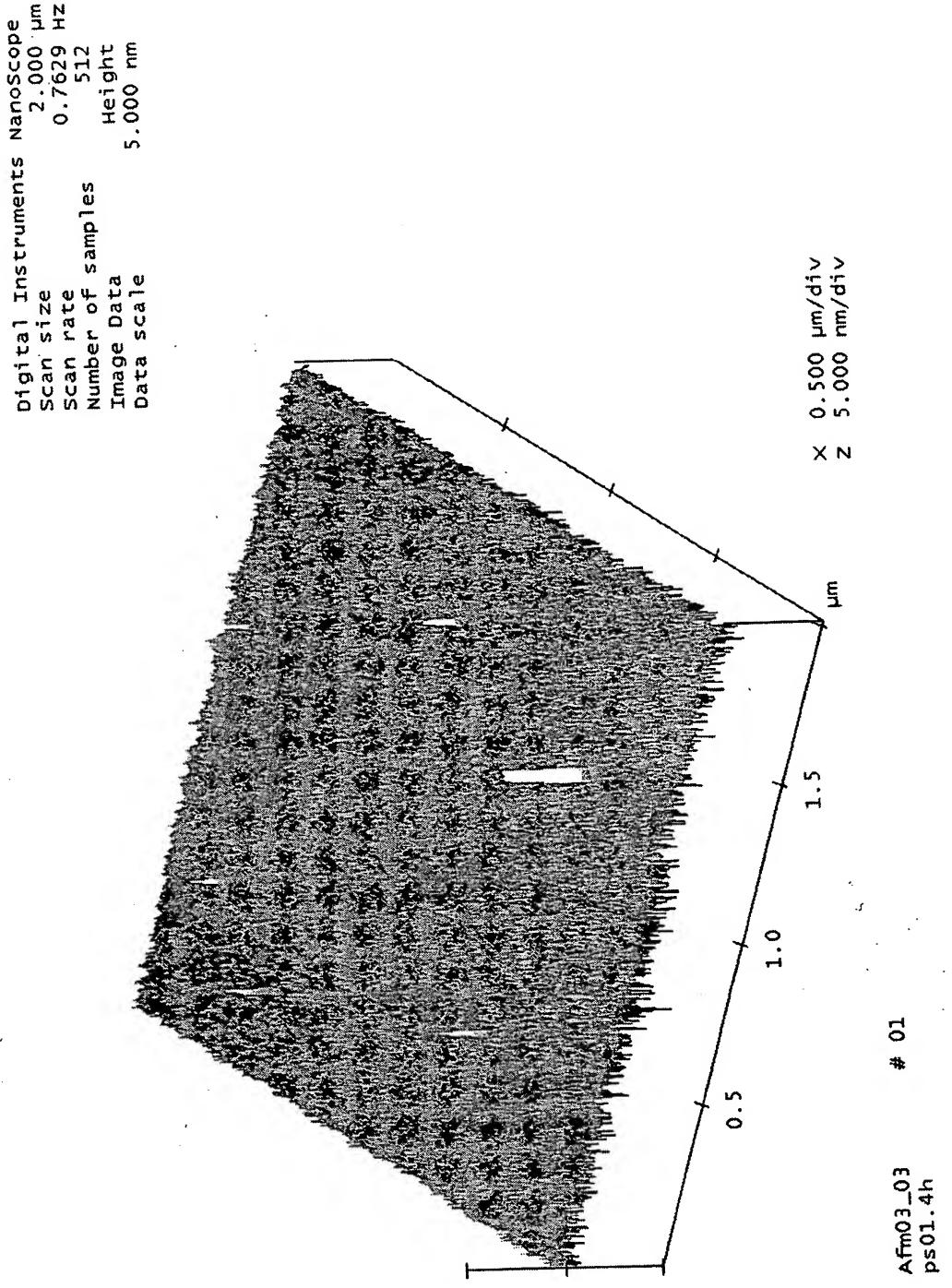
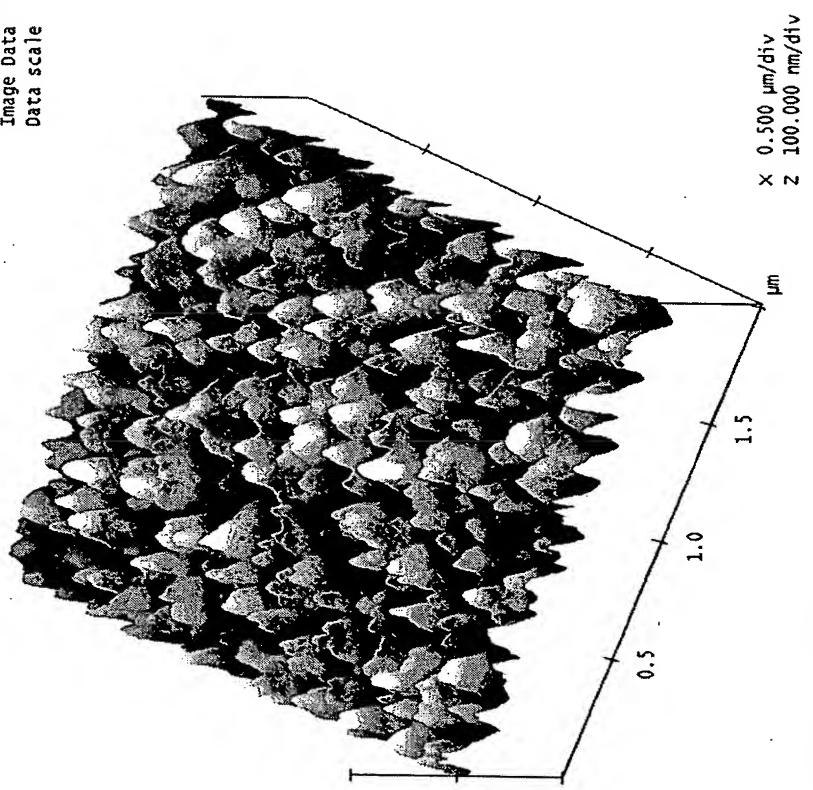


Fig. 10a



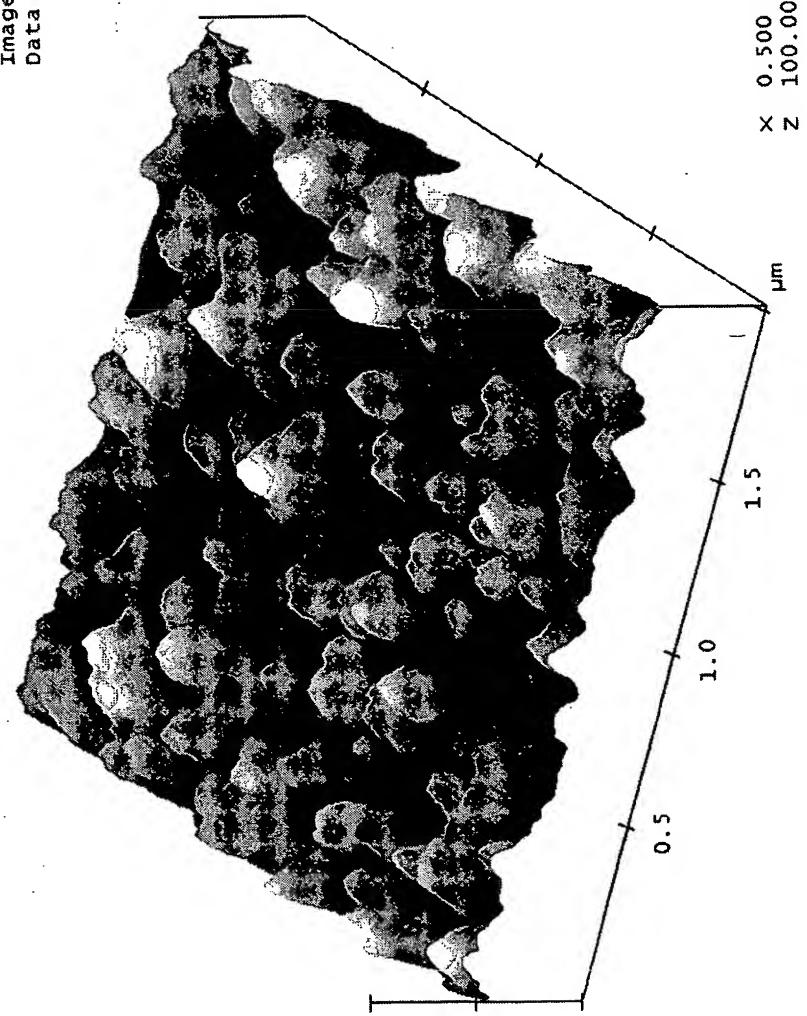
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Number of samples 256
Image Data Height
Data scale 100.00 nm



AFM03_03 #02
ps02b.2h

Fig. 10b

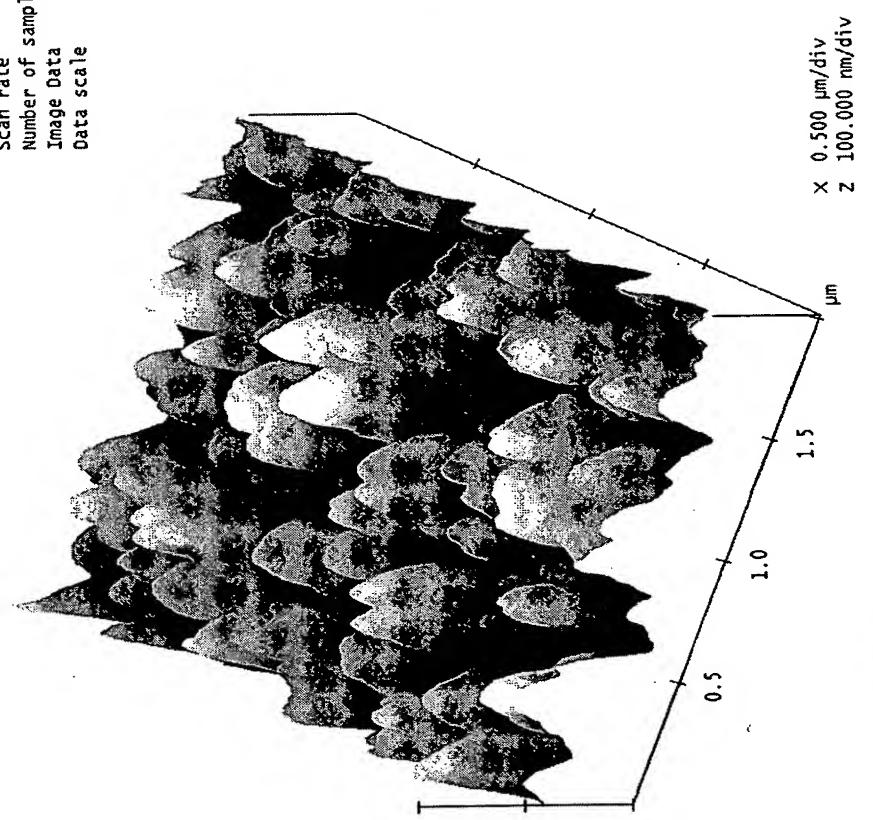
Digital Instruments Nanoscope
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AFM03_03 # 03
ps03b.2h

Fig. 10c

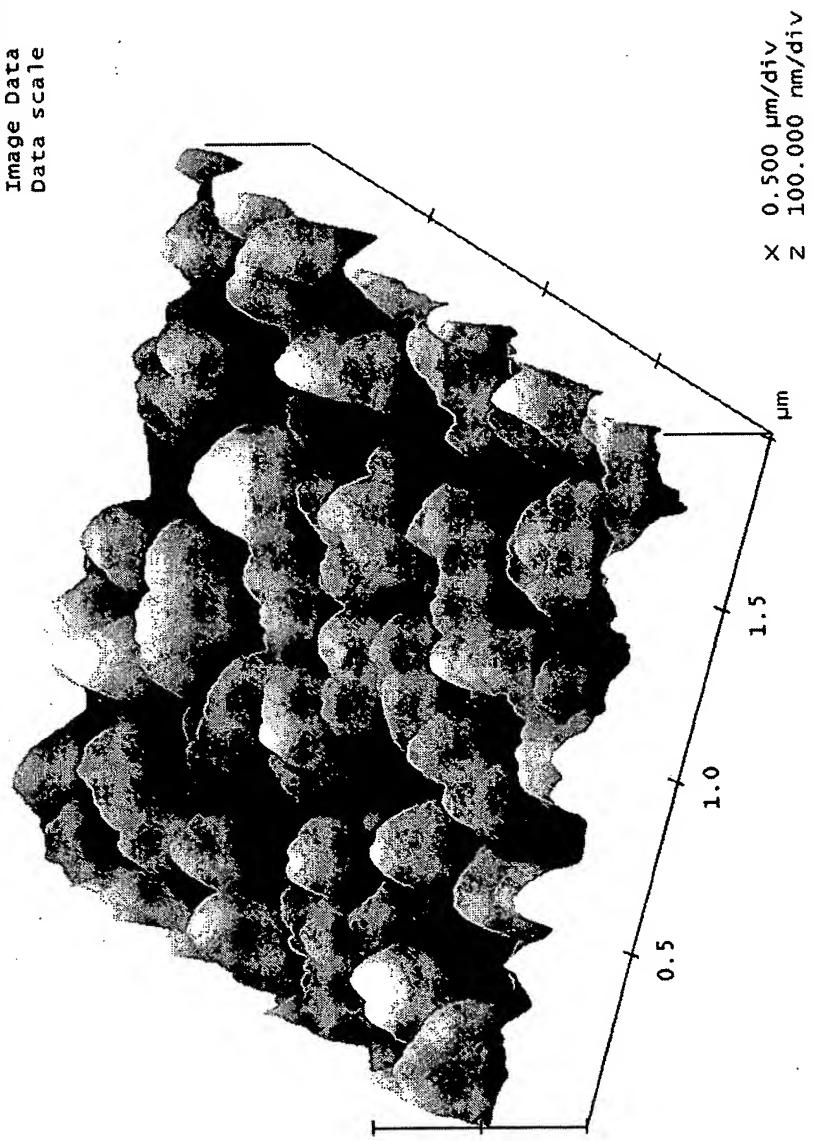
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AFM03_03 # 06
ps06_2h

Fig. 10d

Digital Instruments Nanoscope
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Number of samples 256
Image Data Height
Data scale 100.00 nm



AFM03_03
ps01.4h # 07

Fig. 10e

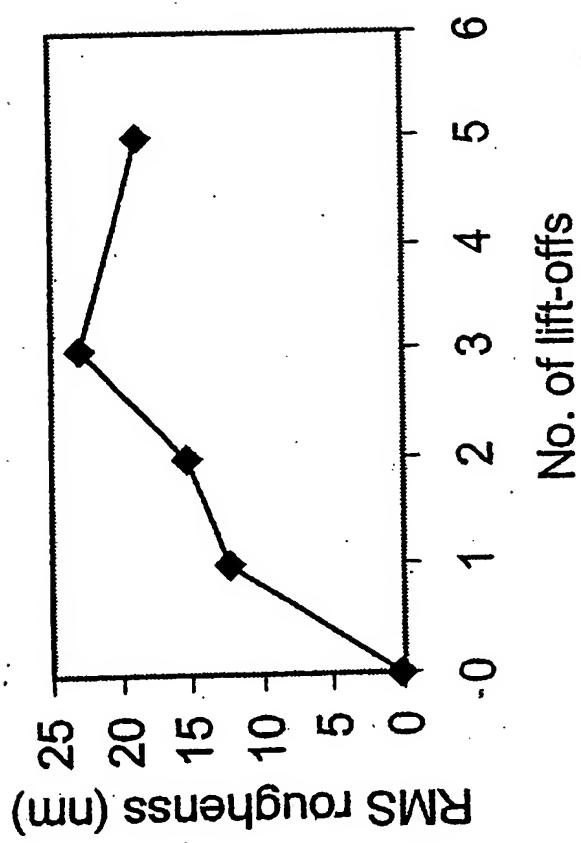


Fig. 10f